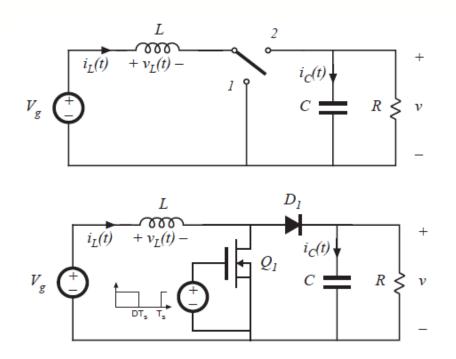
### Johns Hopkins Engineering

### Power Electronics 525.725

Module 2 Lecture 2a
Boost Converter Simulink Simulation



### **Boost Converter**



$$V_g = 48 \text{ V}$$
 $V = 120 \text{ V}$ 
 $P_{\text{out}} = 150 \text{ W}$ 
 $f_{sw} = 100 \text{ kHz}$ 
 $\Delta i_L = 20\% I_L$ 
 $\Delta v = 100mV$ 

### Johns Hopkins Engineering

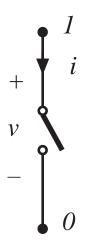
### **Power Electronics 525.725**

Module 2 Lecture 2b Switch realization, losses, and efficiency of a Switching Converter



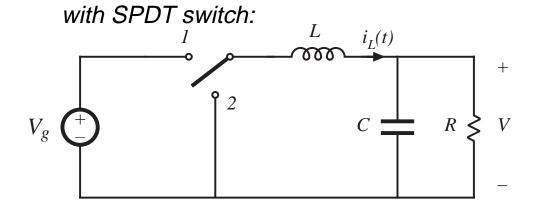
### SPST (single-pole single-throw) switches

SPST switch, with voltage and current polarities defined

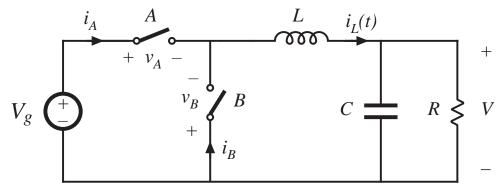


All power semiconductor devices function as SPST switches.

#### **Buck converter**



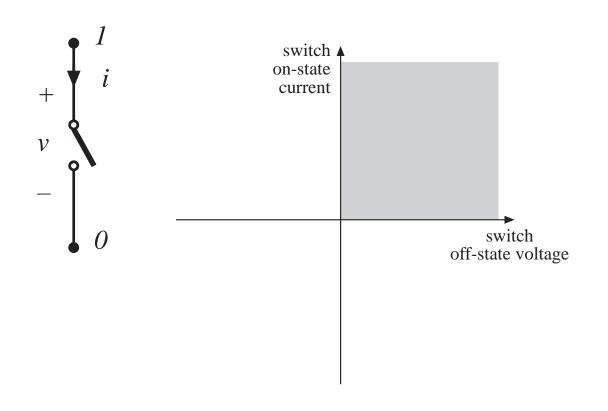
with two SPST switches:



### Realization of SPDT switch using two SPST switches

- A nontrivial step: two SPST switches are not exactly equivalent to one SPDT switch
- It is possible for both SPST switches to be simultaneously ON or OFF
- Behavior of converter is then significantly modified
   —discontinuous conduction modes (ch. 5)
- Conducting state of SPST switch may depend on applied voltage or current —for example: diode

# Quadrants of SPST switch operation

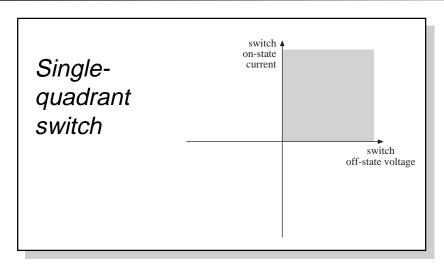


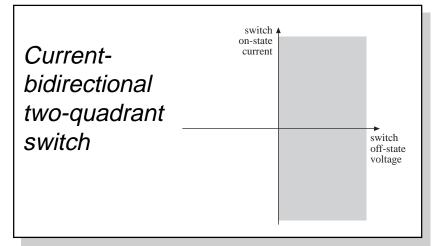
A single-quadrant switch example:

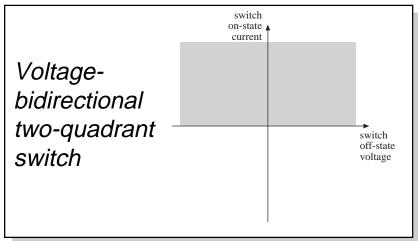
ON-state: i > 0

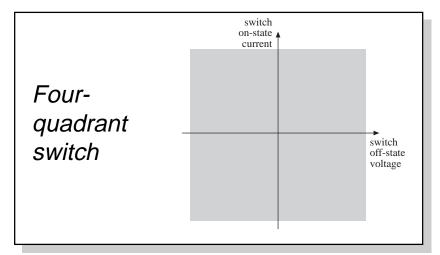
*OFF-state: v* > *0* 

# Some basic switch applications

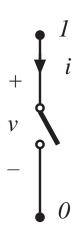








# 4.1.1. Single-quadrant switches



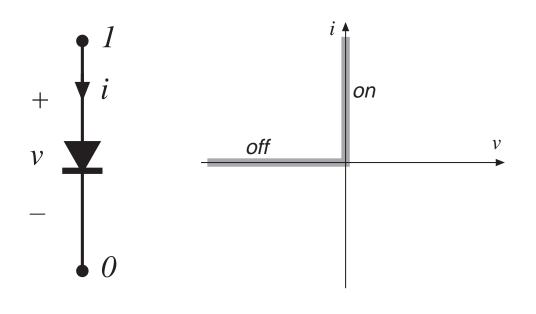
Active switch: Switch state is controlled exclusively by a third terminal (control terminal).

**Passive switch:** Switch state is controlled by the applied current and/or voltage at terminals 1 and 2.

**SCR:** A special case — turn-on transition is active, while turn-off transition is passive.

**Single-quadrant switch:** on-state i(t) and off-state v(t) are unipolar.

### The diode

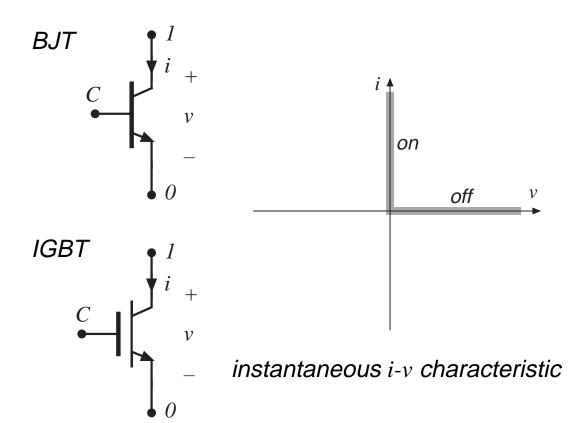


Symbol

instantaneous i-v characteristic

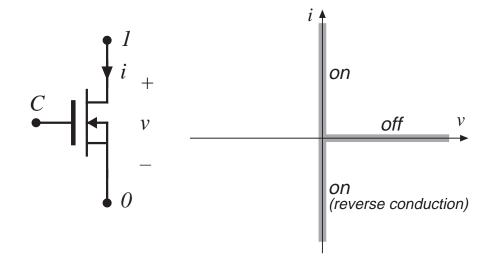
- A passive switch
- Single-quadrant switch:
- can conduct positive onstate current
- can block negative offstate voltage
- provided that the intended on-state and off-state operating points lie on the diode i-v characteristic, then switch can be realized using a diode

# The Bipolar Junction Transistor (BJT) and the Insulated Gate Bipolar Transistor (IGBT)



- An active switch, controlled by terminal C
- Single-quadrant switch:
- can conduct positive onstate current
- can block positive off-state voltage
- provided that the intended on-state and off-state operating points lie on the transistor i-v characteristic, then switch can be realized using a BJT or IGBT

# The Metal-Oxide Semiconductor Field Effect Transistor (MOSFET)

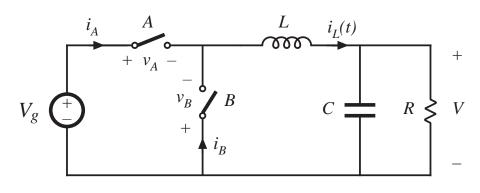


Symbol instantaneous i-v characteristic

- An active switch, controlled by terminal C
- Normally operated as singlequadrant switch:
- can conduct positive on-state current (can also conduct negative current in some circumstances)
- can block positive off-state voltage
- provided that the intended onstate and off-state operating points lie on the MOSFET i-v characteristic, then switch can be realized using a MOSFET

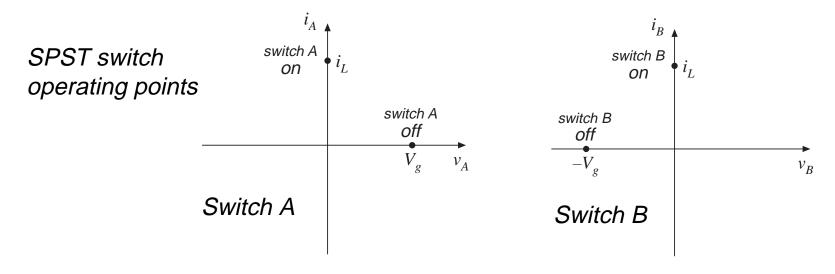
# Realization of switch using transistors and diodes

#### Buck converter example

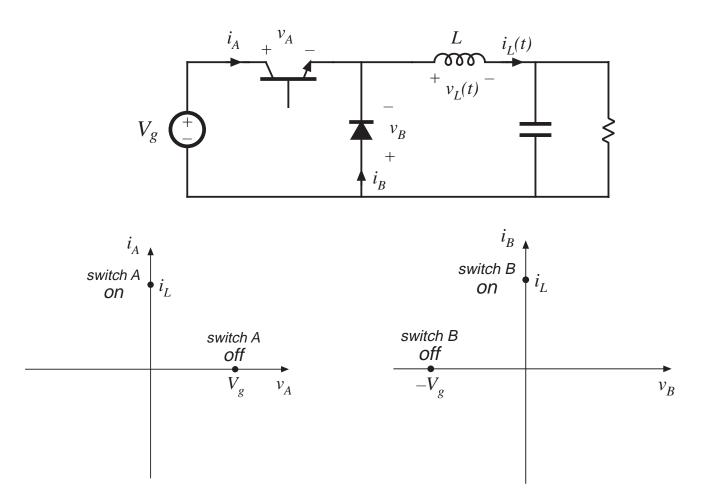


Switch A: transistor

Switch B: diode

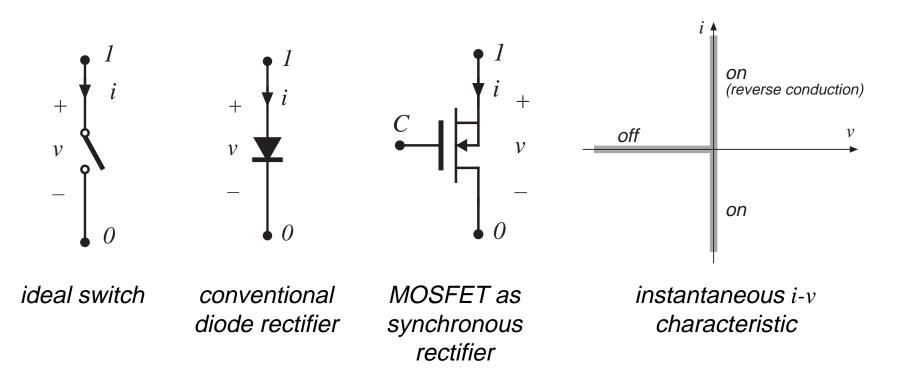


# Realization of buck converter using single-quadrant switches

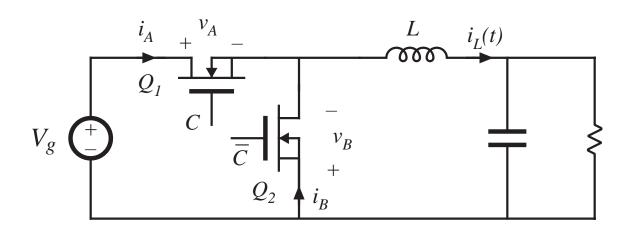


### 4.1.5. Synchronous rectifiers

Replacement of diode with a backwards-connected MOSFET, to obtain reduced conduction loss



### Buck converter with synchronous rectifier



- MOSFET Q<sub>2</sub> is controlled to turn on when diode would normally conduct
- Semiconductor conduction loss can be made arbitrarily small, by reduction of MOSFET onresistances
- Useful in lowvoltage high-current applications

# Converter Efficiency

$$\eta = \frac{P_{out}}{P_{in}} = \frac{V_{out}I_{out}}{V_{out}I_{out} + P_{loss}}$$

$$P_{loss} = P_{sw-cond} + P_{sw-switch} + P_{ind-core} + P_{ind-copper}$$

 $P_{sw-switch}$ : Switching loss of device

P<sub>sw-cond</sub>: Conduction loss of device

 $P_{ind-core}$ : Inductor core loss

 $P_{ind-copper}$ : Inductor copper "conduction" loss

# **Device Loss Contributors**

- Switching Loss Energy is lost during the "main" semiconductor switching transitions, via several mechanisms
  - Transistor switching times "Cross-over" loss
  - Diode stored charge "diode recovery" loss"
  - Energy stored in device capacitances "CV^2" loss

#### 2. Conduction Loss -

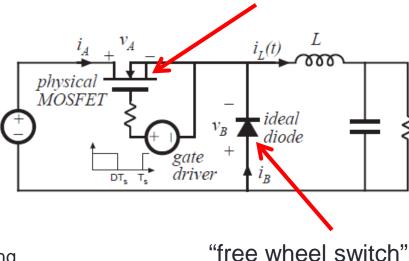
- I^2xR loss in MOSFET
- Von x I loss in IGBT and diode

#### **Main Switch:**

An active switch which charges or stores energy in the inductor.

#### Free Wheel Switch:

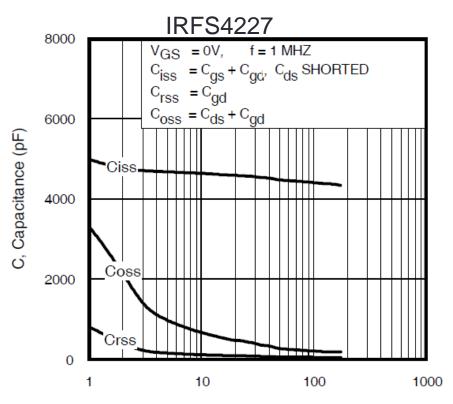
The free wheel switch is the switch which keeps the current flowing in an inductor once the main switch has turned off and is typically a diode rectifier or switch acting as a synchronous rectifier.

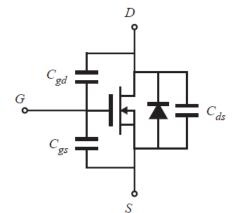


In General, we will only consider switching loss in the main switch and conduction loss in the main and free wheel switch

"main switch"

# MOSFET Data Sheet Capacitances





$$C_{iss} = C_{GS} + C_{GD}, C_{DS}$$
 Shorted

$$C_{rss} = C_{GD}$$
 "Miller Capacitance"

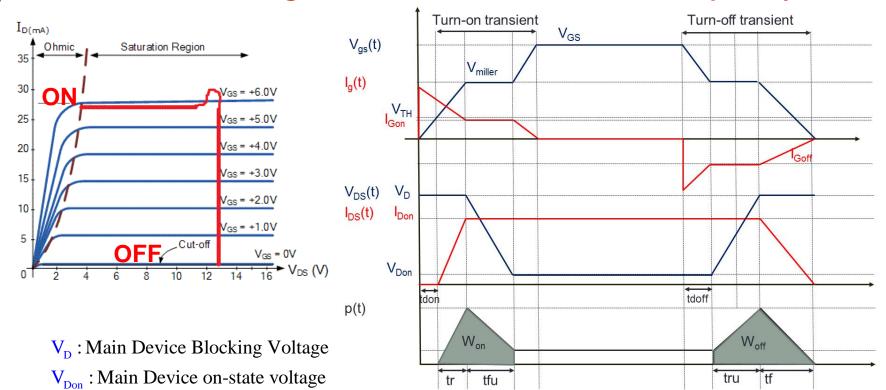
$$C_{oss} = C_{DS} + C_{GD}$$

#### Coss and Crss VERY nonlinear!!

V<sub>DS</sub>, Drain-to-Source Voltage (V)

C <sub>iss</sub>	Input Capacitance	 4600		$V_{GS} = 0V$
Coss	Output Capacitance	460	pF	$V_{DS} = 25V$
$C_{res}$	Reverse Transfer Capacitance	 91		f = 1.0MHz,
C <sub>oss</sub> eff.	Effective Output Capacitance	 360		$V_{GS} = 0V, V_{DS} = 0V \text{ to } 160V$

### MOSFET Switching Loss - MOSFET OFF to ON Trajectory



V<sub>TH</sub>: Main Device threshold voltage "voltage at which device starts to conduct"

tdon: The time it takes for the gate tou source voltage to reach the threshold voltage

 $V_{GS}$ : Peak applied gate to source voltage

p(t): Instantaneous power dissipation " $V_{DS}(t) \times I_{DS}(t)$ "

I<sub>Don</sub>: Main Switch Peak Current "average inductor current"

"assume small ripple approximation for main device current when calculating switching loss"

# Calculating Miller and Threshold Voltage

- Pick two points from curve.
   Select the drain current values corresponding to vertical lines (less error)
- Read corresponding gate-tosource voltages on the horizontal axis
- 3. Calculate miller voltage and threshold voltages and adjust for temperature per the formulas:

$$I_{D1} = K \cdot (V_{GS1} - V_{TH})^{2}$$

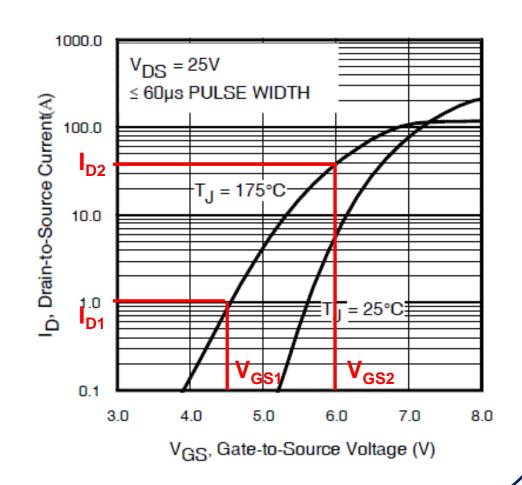
$$I_{D2} = K \cdot (V_{GS2} - V_{TH})^{2}$$

$$C_{D1} = K \cdot (V_{GS2} - V_{TH})^{2}$$

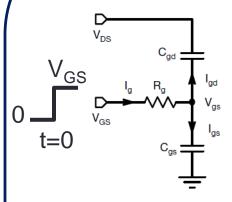
Solve for K and  $V_{TH}$ 

$$V_{miller} = V_{TH} + \sqrt{\frac{I_{load}}{K}}$$

$$\Delta V_{\scriptscriptstyle ADJ} = \! \left( T_{\scriptscriptstyle j} - T_{\scriptscriptstyle curve} \right) \! \cdot \! T_{\scriptscriptstyle C}$$



### MOSFET Switching Loss - Determine Cross-over time



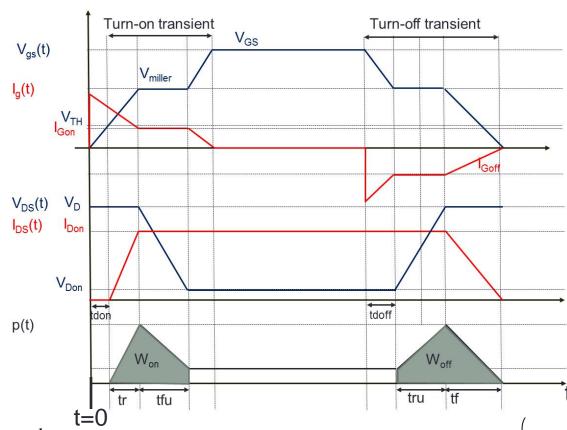
Determine tdon and tr:

$$I_{g}(t) = \frac{V_{GS} - V_{gs}(t)}{R_{g}}$$

$$I_{g}(t) = I_{gs}(t) + I_{gd}(t)$$

$$I_{gs}(t) = C_{gs} \frac{dV_{gs}(t)}{dt}$$

$$I_{gd}(t) = C_{gd} \left( V_{DS} \right) \frac{d \left( V_{gs}(t) - V_{DS}(t) \right)}{dt}$$



Since  $V_{DS}(t)$  is constant during this interval

$$I_{gd}(t) = C_{gd}(V_{DS}) \frac{dV_{gs}(t)}{dt}$$

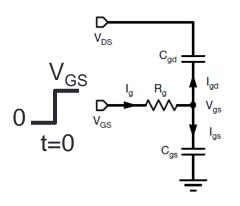
$$I_{g}(t) = (C_{gs} + C_{gd}(V_{DS})) \frac{dV_{gs}(t)}{dt}$$

$$I_{g}(t) = (C_{gs} + C_{gd}(V_{DS})) \frac{dV_{gs}(t)}{dt}$$
Solving ode
$$V_{gs}(t) = V_{GS} \left(1 - e^{-\frac{t}{R_{G}C_{iss}|_{V_{DS}}}}\right)$$

$$t = R_g \left. C_{iss} \right|_{V_I}$$

$$e^{-\frac{t}{R_G C_{iss}} \left|_{V_{DS}}}$$

### MOSFET Switching Loss – Determine Cross-over time cont.

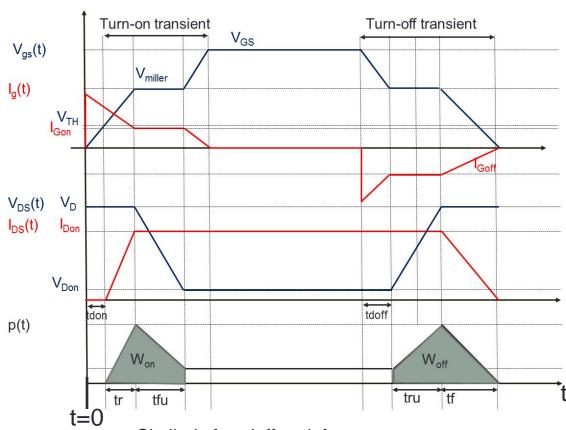


Determine tdon and tr:

$$tdon = R_g \left. C_{iss} \right|_{V_D} \ln \left( \frac{1}{1 - \frac{V_{TH}}{V_{GS}}} \right)$$

$$tdon + tr = R_g C_{iss}|_{V_D} \ln \left(\frac{1}{1 - \frac{V_{miller}}{V_{GS}}}\right)$$

$$tr = R_{g} C_{iss}|_{V_{D}} \ln \left(\frac{1}{1 - \frac{V_{miller}}{V_{GS}}}\right) - R_{g} C_{iss}|_{V_{D}} \ln \left(\frac{1}{1 - \frac{V_{TH}}{V_{GS}}}\right) \qquad tdoff = R_{G} C_{iss}|_{V_{Don}} \ln \left(\frac{V_{GS}}{V_{miller}}\right) \\ tf = R_{G} C_{iss}|_{V_{D}} \ln \left(\frac{V_{miller}}{V_{TH}}\right)$$



Similarly for tdoff and tf:

$$tdoff = R_G C_{iss}|_{V_{Don}} \ln \left(\frac{V_{GS}}{V_{miller}}\right)$$

$$tf = R_G C_{iss} \Big|_{V_D} \ln \left( \frac{V_{miller}}{V_{TH}} \right)$$

### MOSFET Switching Loss – Determine Cross-over time cont.

Determine tfu and recall  $C_{gs}$  is a function of  $V_{DS}$ :

$$I_{g}(t) = \frac{V_{GS} - V_{gs}(t)}{R_{g}} = \frac{V_{GS} - V_{miller}}{R_{g}} = I_{Gon}$$

$$I_{g}(t) = I_{gs}(t)^{0} + I_{gd}(t) = C_{gd}(V_{DS}) \frac{d(V_{gs}(t) - V_{DS}(t))}{dt} V_{DS}(t) V_{DS}(t)$$

Since  $V_{gs}(t)$  is constant during interval

$$\frac{V_{GS} - V_{miller}}{R_g} = -C_{gd} \left( V_{DS} \right) \frac{d V_{DS}(t)}{dt}$$

C<sub>gd</sub> is a function of Vds!!

$$\int_{tfu} \frac{V_{GS} - V_{miller}}{R_g} dt = \int_{V_D}^{V_{Don}} - C_{gd}(V_{DS}) dV_{DS} = \int_{V_{Don}}^{V_D} C_{gd}(V_{DS}) dV_{DS}$$

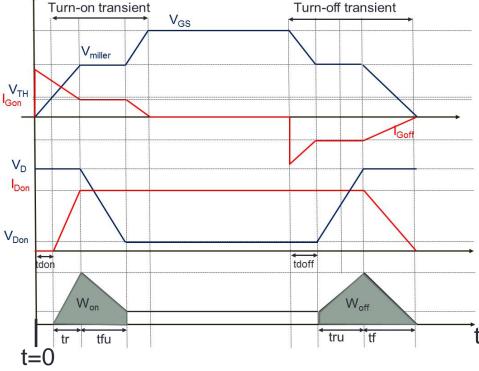
$$\frac{V_{GS} - V_{miller}}{R_g} tfu = \int_{V_{Down}}^{V_D} C_{gd}(V_{DS}) dV_{DS}$$

$$tfu = \frac{R_g \int_{V_{Don}}^{V_D} C_{gd}(V_{DS}) dV_{DS}}{V_{GS} - V_{miller}} \qquad tru = \frac{R_g \int_{V_{Don}}^{V_D} C_{gd}(V_{DS}) dV_{DS}}{V_{miller}}$$

$$V_{gs}(t)$$
 $I_{g}(t)$ 

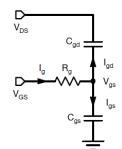


p(t)



#### Similarly for tru:

$$tru = \frac{R_g \int_{V_{Don}}^{V_D} C_{gd}(V_{DS}) dV_{DS}}{V_{miller}}$$

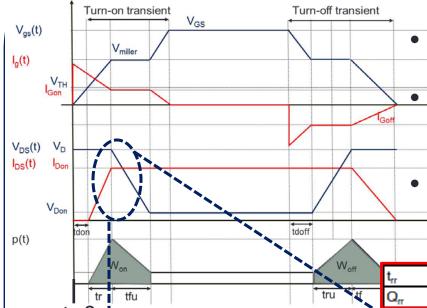


#### Cross-over Switching Energy:

$$W_{on} = \frac{1}{2} t_r V_D I_{Don} + \frac{1}{2} t_{fu} V_D I_{Don}$$

$$W_{off} = \frac{1}{2} t_{ru} V_D I_{Don} + \frac{1}{2} t_f V_D I_{Don}$$

# Diode Reverse Recovery



- Reverse Recovery Time (trr) and Recovery Charge (Qrr) from datasheet
   Diode recovery stored charge Qrr flows through transistor during turn-on, inducing additional loss in MOSFET
  - Diode does not block voltage until peak reverse recovery current has been reached

Idiode(t) I <sub>Don</sub> Irr
Idiode(t)
$V_{DS}(t)$ $V_{D}$
tr Q <sub>rr</sub> tfu

Reverse Recovery Induced Energy

$$i_{diode}(t) = \frac{dQ}{dt}$$

Reverse Recovery Time

Reverse Recovery Charge

$$\int_{t_{rr}} i_{diode}(t)dt = \int_{0}^{Q_{rr}} dQ$$

$$\int_{t_{rr}} i_{diode}(t)dt = \frac{1}{2} t_{rr} I_{rr} = Q_{rr} \Rightarrow I_{rr} = \frac{2Q_{rr}}{t_{rr}}$$

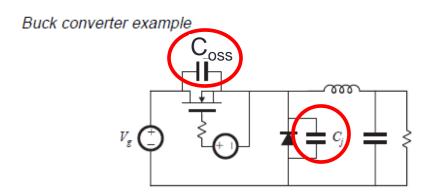
$$W_{rr} = \frac{1}{2} t_{rr} I_{rr} V_D + V_D I_{Don} t_{rr} = Q_{rr} V_D + V_D I_{Don} t_{rr}$$

100

430

nG

# MOSFET Output Capacitance "CV^2 Loss"



 Capacitances that appear effectively in parallel with switch elements are shorted when the switch turns on.
 Their stored energy is lost during the switch turn-on transition. During the switching transition, Coss and Cj are effectiviley in parallel. The energy lost when the MOSFET turns on is:

$$W_{c} = \frac{1}{2} \left( C_{oss(er)} + C_{j(er)} \right) \left( V_{D}^{2} - V_{Don}^{2} \right)$$

Where effective energy related capacitors  $C_{oss(er)}$ ,  $C_{j(er)}$  are linear capacitors with same energy stored at  $V_D$  as nonlinear capacitors  $C_{oss}(v_{ds})$ ,  $C_i(v_{ds})$ 

$$C_{oss(er)} = 2 \frac{\int_{Oss}^{V_{D}} C_{oss}(v_{ds}) v_{ds} dv_{ds}}{\left(V_{D}^{2} - V_{Don}^{2}\right)}$$

$$C_{j(er)} = 2 \frac{\int_{Osn}^{V_{Don}} C_{j}(v_{ds}) v_{ds} dv_{ds}}{\left(V_{D}^{2} - V_{Don}^{2}\right)}$$

$$\mathbf{W}_{c} = \frac{1}{2} \left( 2 \frac{\int\limits_{V_{Don}}^{V_{D}} \mathbf{C}_{oss}(v_{ds})v_{ds}dv_{ds}}{\left(V_{D}^{2} - V_{Don}^{2}\right)} + 2 \frac{\int\limits_{V_{Don}}^{V_{D}} \mathbf{C}_{j}(v_{ds})v_{ds}dv_{ds}}{\left(V_{D}^{2} - V_{Don}^{2}\right)} \right) \left(V_{D}^{2} - V_{Don}^{2}\right)$$

# Calculate Total MOSFET Switching Loss

$$p_{sw}(t) = i_{sw}(t) \cdot v_{sw}(t)$$

$$W_{sw} = \int_{T_{sw}} i_{sw}(t) \cdot v_{sw}(t) dt$$

$$p_{sw-avg} = \frac{1}{T_{sw}} W_{sw} = f_{sw} W_{sw}$$

The switching loss is directly proportional to the switching frequency

$$W_{m-sw} = \underbrace{W_{on} + W_{off}}_{\text{crossover}} + \underbrace{W_{rr}}_{\text{diode}} + \underbrace{W_{c}}_{\text{CV}^2}$$

$$W_{on} = \frac{1}{2} t_r V_D I_{Don} + \frac{1}{2} t_{fu} V_D I_{Don}$$

$$W_{off} = \frac{1}{2} t_{ru} V_D I_{Don} + \frac{1}{2} t_f V_D I_{Don}$$

$$W_{rr} = Q_{rr} V_D + V_D I_{Don} t_{rr}$$

$$W_c = \frac{1}{2} \left( C_{oss(er)} + C_{j(er)} \right) \left( V_D^2 - V_{Don}^2 \right)$$

$$P_{sw-ave} = W_{m-sw} f_{sw}$$

# **MOSFET Conduction Loss**

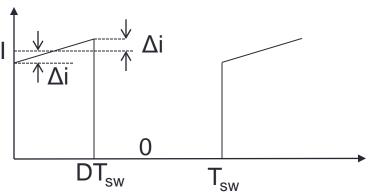
 After MOSFET is fully turned on, it behaves as a resister, given by R<sub>dson</sub>

$$v_{ds}(t) = i(t) \cdot R_{dson}$$

$$p_c(t) = i(t)^2 \cdot R_{dson}$$

$$p_{c-avg} = \frac{1}{T_{sw}} \left( \int_{0}^{DT_{sw}} i(t)^2 \cdot R_{dson} dt + \int_{DT_{sw}}^{T_{sw}} 0 dt \right)$$

# Typical Switch Current waveform during conduction



$$p_{c-avg} = \frac{1}{T_{sw}} \left( \int_{0}^{DT_{sw}} \left( (I - \Delta i) + \frac{2\Delta i}{DT_{sw}} t \right)^{2} \cdot R_{dson} dt + \int_{DT_{sw}}^{T_{sw}} 0 dt \right)$$

$$p_{c-avg} = \frac{1}{3} R_{dson} D \left( 3I^2 + \Delta i^2 \right)$$

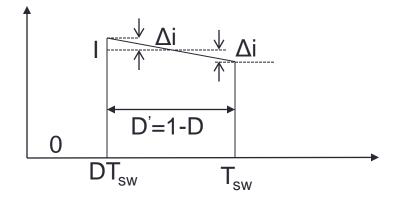
in general:

$$p_{c-avg} = I_{rms}^{2} R_{dson}$$

can also use simulation to calcualte rms current in switch

# Diode Loss - Conduction Loss only

- Diode turns on without cross over loss in most cases
- Majority loss in diode comes from conduction loss
- Reverse recovery loss is induced in the adjacent switch



$$v_{diode}(t) = v_{on}$$

$$p_{cd}(t) = i(t) \cdot v_{on}$$

$$p_{cd-avg} = \frac{1}{T_{sw}} \left( \int_{0}^{DT_{sw}} 0 dt + \int_{DT_{sw}}^{T_{sw}} i(t) \cdot v_{on} dt \right)$$

$$p_{cd-avg} = \frac{1}{T_{sw}} \left( \int_{0}^{DT_{sw}} 0 dt + \int_{DT_{sw}}^{T_{sw}} \left( I + \Delta i - \left( \frac{2\Delta i}{DT_{sw}} \right) (t - DT_{sw}) \right) \cdot v_{on} dt \right)$$

$$p_{cd-avg} = (1 - D) Iv_{on}$$

# **Total Loss Summary**

- MOSFET Total loss
  - Switching
  - Conducting
- Diode Total loss
  - Conducting
- If using MOSFET in replace of free-wheel diode
  - Conducting (I<sub>rms</sub>^2)R<sub>dson</sub>

$$p_{mloss} = p_{sw-avg} + p_{c-avg}$$

$$p_{dloss} = p_{sw-avg} + p_{cd-avg}$$

# Converter Efficiency

$$\eta = \frac{P_{out}}{P_{in}} = \frac{V_{out}I_{out}}{V_{out}I_{out} + P_{loss}}$$

$$P_{loss} = P_{sw-cond} + P_{sw-switch} + P_{ind-core} + P_{ind-copper}$$

 $P_{sw-switch}$ : Switching loss of device =  $p_{sw-avg}$ 

 $P_{\text{sw-cond}}$ : Conduction loss of device =  $p_{c-avg} + p_{cd-avg}$ 

 $P_{ind-core}$ : Inductor core loss

 $P_{ind-copper}$ : Inductor copper "conduction" loss

### Inductor Loss

Inductor Copper "conduction" loss

$$P_{ind-copper} = I_{ind-rms}^2 \times R_{ind-esr}$$
 (esr-Equivalent series resistance)

$$I_{ind-rms} = I \sqrt{1 + \frac{1}{3} \left(\frac{\Delta i}{I}\right)^2}$$
 "Appendix A of Erickson Fig. A.2"

Assume:

$$P_{ind-core} = P_{ind-copper}$$